Notice of References Cited Application/Control No. 10/037,829 Examiner Y. Lee Application/Control No. Applicant(s)/Patent Under Reexamination MINAUDO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,619,036 A	04-1997	Salvio et al.	348/148
	В	US-2002/0067413 A1	06-2002	McNamara, Dennis Patrick	348/216.1
	С	US-2003/0169491 A1	09-2003	Bender et al.	359/350
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	j	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classifi cation
	N					
	-0-					
	Р					
	Q					
	R					
	S	·				
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	·
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.